

US005981306A

United States Patent [19]

Burrows et al.

[11] **Patent Number:**

5,981,306

[45] **Date of Patent:**

Nov. 9, 1999

[54] METHOD FOR DEPOSITING INDIUM TIN OXIDE LAYERS IN ORGANIC LIGHT EMITTING DEVICES

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[21] Appl. No.: 08/928,800

[22] Filed: Sep. 12, 1997

[51] Int. Cl.⁶ H01L 51/40

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[57] ABSTRACT

A method is disclosed for fabricating organic light emitting devices (OLEDS) containing an indium tin oxide (ITO) layer that is deposited onto a fragile layer. The ITO layer is fabricated using a low, non-damaging, ITO deposition rate until a protective ITO layer is formed, at which point the ITO deposition rate is increased to a substantially higher deposition rate without causing damage to the underlying layers. OLEDs fabricated using the accelerated ITO deposition rate could be made with I–V characteristics having no practically discernible difference from the I–V characteristics of an OLED in which the ITO deposition rate was kept at a low deposition rate throughout the ITO deposition process.

5 Claims, 4 Drawing Sheets

